



Please note that Cypress is an Infineon Technologies Company.

The document following this cover page is marked as “Cypress” document as this is the company that originally developed the product. Please note that Infineon will continue to offer the product to new and existing customers as part of the Infineon product portfolio.

Continuity of document content

The fact that Infineon offers the following product as part of the Infineon product portfolio does not lead to any changes to this document. Future revisions will occur when appropriate, and any changes will be set out on the document history page.

Continuity of ordering part numbers

Infineon continues to support existing part numbers. Please continue to use the ordering part numbers listed in the datasheet for ordering.

16-Kbit (2K × 8) Serial (I²C) Automotive-E F-RAM

Features

- 16-Kbit ferroelectric random access memory (F-RAM) logically organized as 2K × 8
 - High-endurance 10 trillion (10¹³) read/writes
 - 121-year data retention (See [Data Retention and Endurance on page 10](#))
 - NoDelay™ writes
 - Advanced high-reliability ferroelectric process
- Fast 2-wire Serial interface (I²C)
 - Up to 1-MHz frequency
 - Direct hardware replacement for serial (I²C) EEPROM
 - Supports legacy timings for 100 kHz and 400 kHz
- Low power consumption
 - 120 μA active current at 100 kHz
 - 20 μA (typ) standby current
- Voltage operation: V_{DD} = 3.0 V to 3.6 V
- Automotive-E temperature: -40 °C to +125 °C
- 8-pin small outline integrated circuit (SOIC) package
- AEC Q100 Grade 1 compliant
- Restriction of hazardous substances (RoHS) compliant

Functional Description

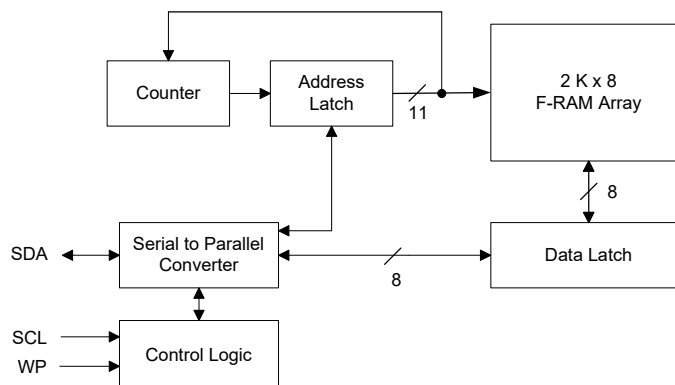
The CY15B016J is a 16-Kbit nonvolatile memory employing an advanced ferroelectric process. A ferroelectric random access memory or F-RAM is nonvolatile and performs reads and writes similar to a RAM. It provides reliable data retention for 121 years while eliminating the complexities, overhead, and system-level reliability problems caused by EEPROM and other nonvolatile memories.

Unlike EEPROM, the CY15B016J performs write operations at bus speed. No write delays are incurred. Data is written to the memory array immediately after each byte is successfully transferred to the device. The next bus cycle can commence without the need for data polling. In addition, the product offers substantial write endurance compared with other nonvolatile memories. Also, F-RAM exhibits much lower power during writes than EEPROM since write operations do not require an internally elevated power supply voltage for write circuits. The CY15B016J is capable of supporting 10¹³ read/write cycles, or 10 million times more write cycles than EEPROM.

These capabilities make the CY15B016J ideal for nonvolatile memory applications, requiring frequent or rapid writes. Examples range from data logging, where the number of write cycles may be critical, to demanding industrial controls where the long write time of EEPROM can cause data loss. The combination of features allows more frequent data writing with less overhead for the system.

The CY15B016J provides substantial benefits to users of serial (I²C) EEPROM as a hardware drop-in replacement. The device specifications are guaranteed over an automotive-e temperature range of -40 °C to +125 °C.

Logic Block Diagram

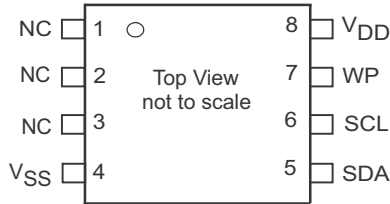


Contents

| | | | |
|--|-----------|--|-----------|
| Pinout | 3 | Capacitance | 10 |
| Pin Definitions | 3 | Thermal Resistance | 10 |
| Functional Overview | 4 | AC Test Loads and Waveforms | 11 |
| Memory Architecture | 4 | AC Test Conditions | 11 |
| I2C Interface | 4 | AC Switching Characteristics | 12 |
| STOP Condition (P) | 4 | Power Cycle Timing | 13 |
| START Condition (S) | 4 | Ordering Information | 14 |
| Data/Address Transfer | 5 | Ordering Code Definitions | 14 |
| Acknowledge/No-acknowledge | 5 | Package Diagram | 15 |
| Slave Device Address | 6 | Acronyms | 16 |
| Addressing Overview (Word Address) | 6 | Document Conventions | 16 |
| Data Transfer | 6 | Units of Measure | 16 |
| Memory Operation | 6 | Document History Page | 17 |
| Write Operation | 6 | Sales, Solutions, and Legal Information | 18 |
| Read Operation | 7 | Worldwide Sales and Design Support | 18 |
| Endurance | 8 | Products | 18 |
| Maximum Ratings | 9 | PSoC® Solutions | 18 |
| Operating Range | 9 | Cypress Developer Community | 18 |
| DC Electrical Characteristics | 9 | Technical Support | 18 |
| Data Retention and Endurance | 10 | | |
| Example of an F-RAM Life Time | | | |
| in an AEC-Q100 Automotive Application | 10 | | |

Pinout

Figure 1. 8-pin SOIC pinout



Pin Definitions

| Pin Name | I/O Type | Description |
|-----------------|--------------|---|
| SDA | Input/Output | Serial Data/Address. This is a bi-directional pin for the I ² C interface. It is open-drain and is intended to be wire-AND'd with other devices on the I ² C bus. The input buffer incorporates a Schmitt trigger for noise immunity and the output driver includes slope control for falling edges. An external pull-up resistor is required. |
| SCL | Input | Serial Clock. The serial clock pin for the I ² C interface. Data is clocked out of the device on the falling edge, and into the device on the rising edge. |
| WP | Input | Write Protect. When tied to V _{DD} , addresses in the entire memory map will be write-protected. When WP is connected to ground, all addresses are write enabled. This pin is pulled down internally. |
| V _{SS} | Power supply | Ground for the device. Must be connected to the ground of the system. |
| V _{DD} | Power supply | Power supply input to the device. |
| NC | NC | No Connect. Die pads are not connected to the package pin. |

Functional Overview

The CY15B016J is a serial F-RAM memory. The memory array is logically organized as 2,048 × 8 bits and is accessed using an industry-standard I²C interface. The functional operation of the F-RAM is similar to serial (I²C) EEPROM. The major difference between the CY15B016J and a serial (I²C) EEPROM with the same pinout is the F-RAM's superior write performance, high endurance, and low power consumption.

Memory Architecture

When accessing the CY15B016J, the user addresses 2K locations of eight data bits each. These eight data bits are shifted in or out serially. The addresses are accessed using the I²C protocol, which includes a slave address (to distinguish other non-memory devices), a row address, and a segment address. The row address consists of 8-bits that specify one of the 256 rows. The 3-bit segment address specifies one of the 8 segments within each row. The complete address of 11-bits specifies each byte address uniquely.

The access time for the memory operation is essentially zero, beyond the time needed for the serial protocol. That is, the memory is read or written at the speed of the I²C bus. Unlike a serial (I²C) EEPROM, it is not necessary to poll the device for a ready condition because writes occur at bus speed. By the time a new bus transaction can be shifted into the device, a write

operation is complete. This is explained in more detail in the interface section.

Note that the CY15B016J contains no power management circuits other than a simple internal power-on reset. It is the user's responsibility to ensure that V_{DD} is within data sheet tolerances to prevent incorrect operation.

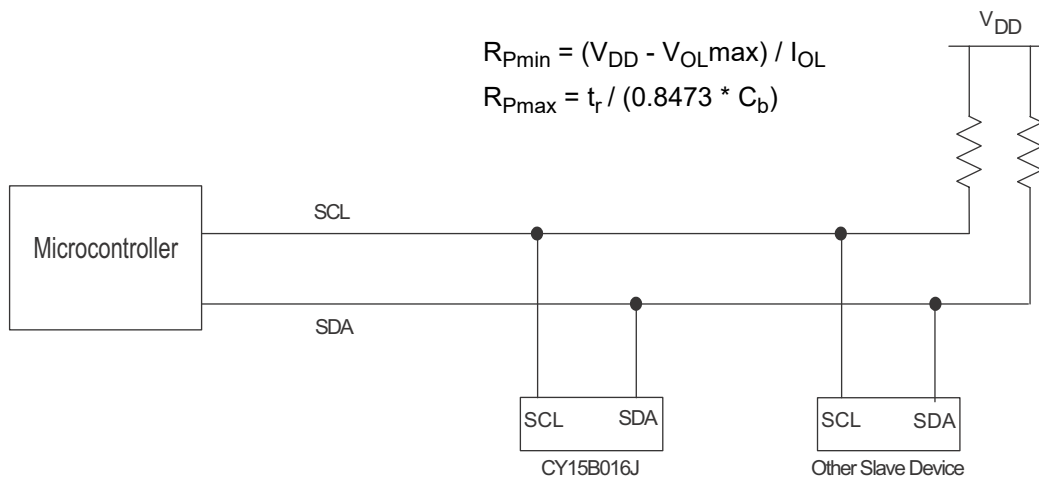
I²C Interface

The CY15B016J employs a bi-directional I²C bus protocol using few pins or board space. Figure 2 illustrates a typical system configuration using the CY15B016J in a microcontroller-based system. The industry standard I²C bus is familiar to many users but is described in this section.

By convention, any device that is sending data onto the bus is the transmitter while the target device for this data is the receiver. The device that is controlling the bus is the master. The master is responsible for generating the clock signal for all operations. Any device on the bus that is being controlled is a slave. The CY15B016J is always a slave device.

The bus protocol is controlled by transition states in the SDA and SCL signals. There are four conditions including START, STOP, data bit, or acknowledge. Figure 3 on page 5 and Figure 4 on page 5 illustrates the signal conditions that specify the four states. Detailed timing diagrams are shown in the electrical specifications section.

Figure 2. System Configuration using Serial (I²C) nvSRAM



STOP Condition (P)

A STOP condition is indicated when the bus master drives SDA from LOW to HIGH while the SCL signal is HIGH. All operations using the CY15B016J should end with a STOP condition. If an operation is in progress when a STOP is asserted, the operation will be aborted. The master must have control of SDA in order to assert a STOP condition.

START Condition (S)

A START condition is indicated when the bus master drives SDA from HIGH to LOW while the SCL signal is HIGH. All commands should be preceded by a START condition. An operation in progress can be aborted by asserting a START condition at any time. Aborting an operation using the START condition will ready the CY15B016J for a new operation.

If during operation the power supply drops below the specified V_{DD} minimum, the system should issue a START condition prior to performing another operation.

Figure 3. START and STOP Conditions

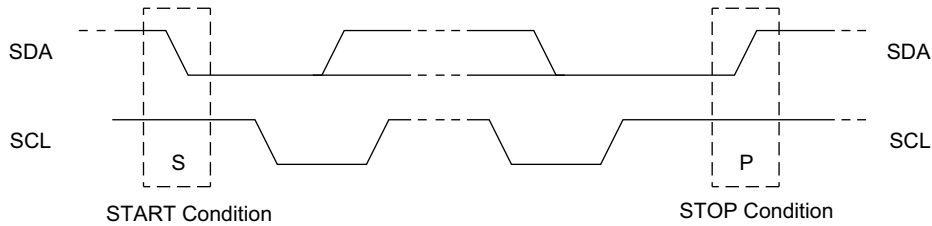
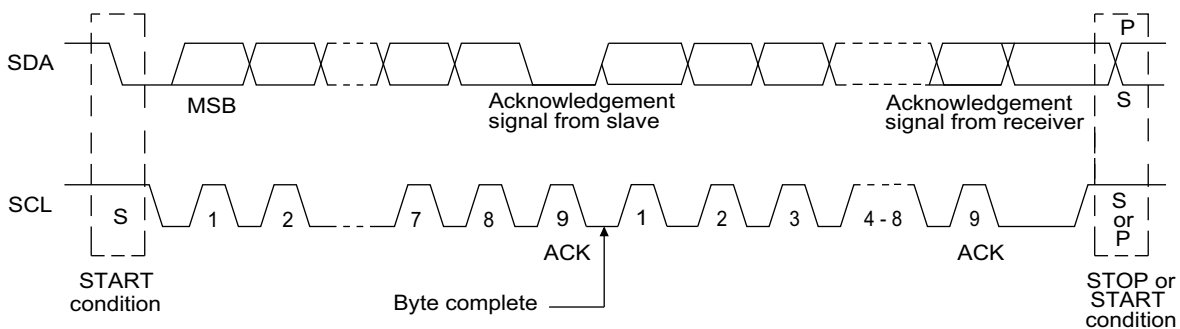


Figure 4. Data Transfer on the I²C Bus



Data/Address Transfer

All data transfers (including addresses) take place while the SCL signal is HIGH. Except under the two conditions described above, the SDA signal should not change while SCL is HIGH.

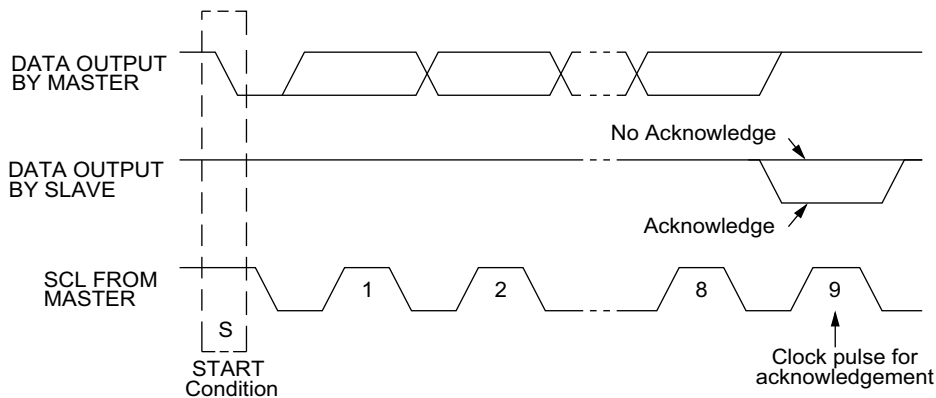
Acknowledge/No-acknowledge

The acknowledge takes place after the 8th data bit has been transferred in any transaction. During this state the transmitter should release the SDA bus to allow the receiver to drive it. The receiver drives the SDA signal LOW to acknowledge receipt of the byte. If the receiver does not drive SDA LOW, the condition is a no-acknowledge and the operation is aborted.

The receiver would fail to acknowledge for two distinct reasons. First is that a byte transfer fails. In this case, the no-acknowledge ceases the current operation so that the device can be addressed again. This allows the last byte to be recovered in the event of a communication error.

Second and most common, the receiver does not acknowledge to deliberately end an operation. For example, during a read operation, the CY15B016J will continue to place data onto the bus as long as the receiver sends acknowledges (and clocks). When a read operation is complete and no more data is needed, the receiver must not acknowledge the last byte. If the receiver acknowledges the last byte, this will cause the CY15B016J to attempt to drive the bus on the next clock while the master is sending a new command such as STOP.

Figure 5. Acknowledge on the I²C Bus

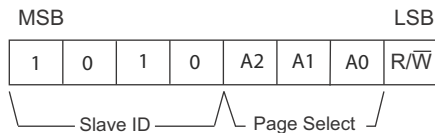


Slave Device Address

The first byte that the CY15B016J expects after a START condition is the slave address. As shown in Figure 6, the slave address contains the device type, the page of memory to be accessed, and a bit that specifies if the transaction is a read or a write.

Bits 7–4 are the device type and should be set to 1010b for the CY15B016J. These bits allow other function types to reside on the I²C bus within an identical address range. Bits 3–1 are the page select. It specifies the 256-byte block of memory that is targeted for the current operation. Bit 0 is the read/write bit (R/W). R/W = '1' indicates a read operation and R/W = '0' indicates a write operation.

Figure 6. Memory Slave Device Address



Addressing Overview (Word Address)

After the CY15B016J (as receiver) acknowledges the slave address, the master can place the word address on the bus for a write operation. The word address is the lower 8-bits of the address to be combined with the 3-bits page select to specify exactly the byte to be written. The complete 11-bit address is latched internally. No word address occurs for a read operation, though the 3-bit page select is latched internally. Reads always use the lower 8-bits that are held internally in the address latch. That is, reads always begin at the address following the previous access. A random read address can be loaded by doing a write operation as explained below.

After transmission of each data byte, just prior to the acknowledge, the CY15B016J increments the internal address latch. This allows the next sequential byte to be accessed with no additional addressing. After the last address (7FFh) is reached, the address latch will roll over to 000h. There is no limit to the number of bytes that can be accessed with a single read or write operation.

Data Transfer

After the address bytes have been transmitted, data transfer between the bus master and the CY15B016J can begin. For a read operation the CY15B016J will place 8 data bits on the bus then wait for an acknowledge from the master. If the acknowledge occurs, the CY15B016J will transfer the next

sequential byte. If the acknowledge is not sent, the CY15B016J will end the read operation. For a write operation, the CY15B016J will accept 8 data bits from the master then send an acknowledge. All data transfer occurs MSB (most significant bit) first.

Memory Operation

The CY15B016J is designed to operate in a manner very similar to other I²C interface memory products. The major differences result from the higher performance write capability of F-RAM technology. These improvements result in some differences between the CY15B016J and a similar configuration EEPROM during writes. The complete operation for both writes and reads is explained below.

Write Operation

All writes begin with a slave address, then a word address. The bus master indicates a write operation by setting the LSB of the slave address (R/W bit) to a '0'. After addressing, the bus master sends each byte of data to the memory and the memory generates an acknowledge condition. Any number of sequential bytes may be written. If the end of the address range is reached internally, the address counter will wrap from 7FFh to 000h.

Unlike other nonvolatile memory technologies, there is no effective write delay with F-RAM. Since the read and write access times of the underlying memory are the same, the user experiences no delay through the bus. The entire memory cycle occurs in less time than a single bus clock. Therefore, any operation including read or write can occur immediately following a write. Acknowledge polling, a technique used with EEPROMs to determine if a write is complete is unnecessary and will always return a ready condition.

Internally, an actual memory write occurs after the 8th data bit is transferred. It will be complete before the acknowledge is sent. Therefore, if the user desires to abort a write without altering the memory contents, this should be done using START or STOP condition prior to the 8th data bit. The CY15B016J uses no page buffering.

The memory array can be write-protected using the WP pin. Setting the WP pin to a HIGH condition (V_{DD}) will write-protect all addresses. The CY15B016J will not acknowledge data bytes that are written to protected addresses. In addition, the address counter will not increment if writes are attempted to these addresses. Setting WP to a LOW state (V_{SS}) will disable the write protect. WP is pulled down internally.

Figure 7 and Figure 8 on page 7 below illustrate a single-byte and multiple-byte write cycles.

Figure 7. Single-Byte Write

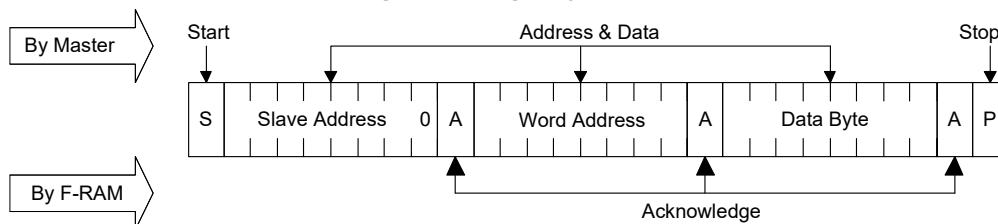
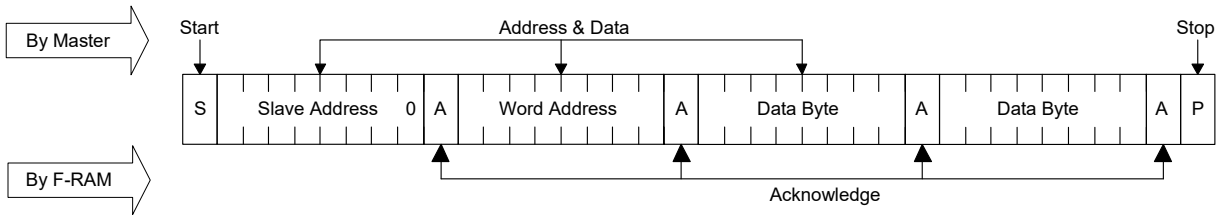


Figure 8. Multi-Byte Write



Read Operation

There are two basic types of read operations. They are current address read and selective address read. In a current address read, the CY15B016J uses the internal address latch to supply the lower 8 address bits. In a selective read, the user performs a procedure to set these lower address bits to a specific value.

Current Address & Sequential Read

As mentioned above the CY15B016J uses an internal latch to supply the lower 8 address bits for a read operation. A current address read uses the existing value in the address latch as a starting place for the read operation. The system reads from the address immediately following that of the last operation.

To perform a current address read, the bus master supplies a slave address with the LSB set to a '1'. This indicates that a read operation is requested. The three page select bits in the slave address specifies the block of memory that is used for the read operation. After receiving the complete slave address, the CY15B016J will begin shifting out data from the current address on the next clock. The current address is the 3-bits from the slave address combined with the 8-bits that were in the internal address latch.

Beginning with the current address, the bus master can read any number of bytes. Thus, a sequential read is simply a current address read with multiple byte transfers. After each byte the internal address counter will be incremented.

Note Each time the bus master acknowledges a byte, this indicates that the CY15B016J should read out the next sequential byte.

There are four ways to properly terminate a read operation. Failing to properly terminate the read will most likely create a bus contention as the CY15B016J attempts to read out additional data onto the bus. The four valid methods are:

1. The bus master issues a no-acknowledge in the 9th clock cycle and a STOP in the 10th clock cycle. This is illustrated in the diagrams below. This is preferred.
2. The bus master issues a no-acknowledge in the 9th clock cycle and a START in the 10th.
3. The bus master issues a STOP in the 9th clock cycle.
4. The bus master issues a START in the 9th clock cycle.

If the internal address reaches 7FFh, it will wrap around to 000h on the next read cycle. Figure 9 and Figure 10 below show the proper operation for current address reads.

Figure 9. Current Address Read

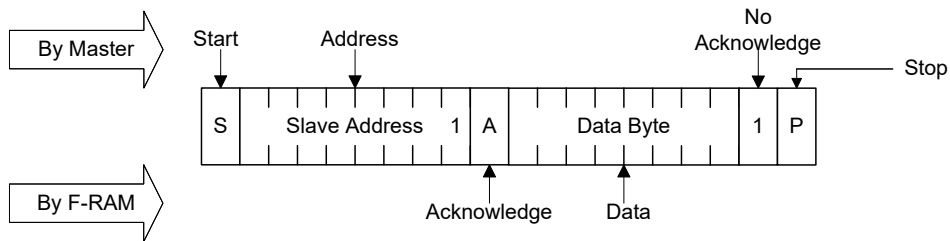
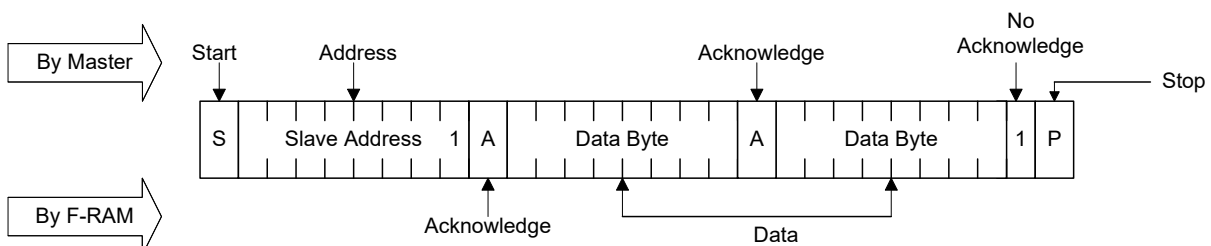


Figure 10. Sequential Read



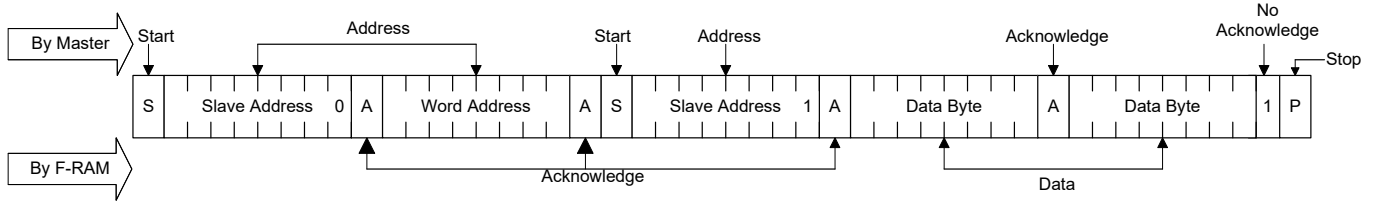
Selective (Random) Read

There is a simple technique that allows a user to select a random address location as the starting point for a read operation. This involves using the first two bytes of a write operation to set the internal address followed by subsequent read operations.

To perform a selective read, the bus master sends out the slave address with the LSB (R/W) set to 0. This specifies a write

operation. According to the write protocol, the bus master then sends the word address byte that is loaded into the internal address latch. After the CY15B016J acknowledges the word address, the bus master issues a START condition. This simultaneously aborts the write operation and allows the read command to be issued with the slave address LSB set to a '1'. The operation is now a current address read.

Figure 11. Selective (Random) Read



Endurance

The Cy15B016J internally operates with a read and restore mechanism. Therefore, endurance cycles are applied for each read or write cycle. The memory architecture is based on an array of rows and columns. Each read or write access causes an endurance cycle for an entire row. In the CY15B016J, a row is 64 bits wide. Every 8-byte boundary marks the beginning of a

new row. Endurance can be optimized by ensuring frequently accessed data is located in different rows. Regardless, FRAM read and write endurance is effectively unlimited at the 1MHz I²C speed. Even at 3000 accesses per second to the same row, 10 years time will elapse before 1 trillion endurance cycles occur.

Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. These user guidelines are not tested.

| | |
|---|---|
| Storage temperature | –65 °C to +150 °C |
| Maximum accumulated storage time | |
| At 150 °C ambient temperature | 1000 h |
| At 125 °C ambient temperature | 11000 h |
| At 85 °C ambient temperature | 121 Years |
| Ambient temperature | |
| with power applied | –55 °C to +125 °C |
| Supply voltage on V_{DD} relative to V_{SS} | –1.0 V to +5.0 V |
| Input voltage | –1.0 V to + 5.0 V and $V_{IN} < V_{DD} + 1.0$ V |
| DC voltage applied to outputs | |
| in High-Z state | –0.5 V to $V_{DD} + 0.5$ V |

| | |
|--|----------------------------|
| Transient voltage (< 20 ns) | |
| on any pin to ground potential | –2.0 V to $V_{DD} + 2.0$ V |
| Package power dissipation capability | |
| ($T_A = 25$ °C) | 1.0 W |
| Surface mount lead soldering temperature | |
| (10 seconds) | +260 °C |
| Electrostatic Discharge Voltage ^[1] | |
| Human Body Model (AEC-Q100-002 Rev. E) | 2 kV |
| Charged Device Model (AEC-Q100-011 Rev. B) | 500 V |
| Latch-up current | > 140 mA |

* Exception: The “ $V_{IN} < V_{DD} + 1.0$ V” restriction does not apply to the SCL and SDA inputs.

Operating Range

| Range | Ambient Temperature (T_A) | V_{DD} |
|--------------|-------------------------------|----------------|
| Automotive-E | –40 °C to +125 °C | 3.0 V to 3.6 V |

DC Electrical Characteristics

Over the [Operating Range](#)

| Parameter | Description | Test Conditions | Min | Typ ^[2] | Max | Unit | |
|-----------------|-----------------------------------|---|----------------------|--------------------|----------------------|------------|---------|
| V_{DD} | Power supply | | 3.0 | 3.3 | 3.6 | V | |
| I_{DD} | Average V_{DD} current | SCL toggling between $V_{DD} - 0.3$ V and V_{SS} , other inputs V_{SS} or $V_{DD} - 0.3$ V. | $f_{SCL} = 100$ kHz | – | – | 120 | μ A |
| | | | $f_{SCL} = 400$ kHz | – | – | 200 | μ A |
| | | | $f_{SCL} = 1$ MHz | – | – | 340 | μ A |
| I_{SB} | Standby current | SCL = SDA = V_{DD} . All other inputs V_{SS} or V_{DD} . Stop command issued. | $T_A = 85$ °C | – | – | 6 | μ A |
| | | | $T_A = 125$ °C | – | – | 20 | μ A |
| I_{LI} | Input leakage current (Except WP) | $V_{SS} \leq V_{IN} \leq V_{DD}$ | –1 | – | +1 | μ A | |
| | Input leakage current (for WP) | $V_{SS} \leq V_{IN} \leq V_{DD}$ | –1 | – | +100 | μ A | |
| I_{LO} | Output leakage current | $V_{SS} \leq V_{IN} \leq V_{DD}$ | –1 | – | +1 | μ A | |
| V_{IH} | Input HIGH voltage | | $0.75 \times V_{DD}$ | – | $V_{DD} + 0.3$ | V | |
| V_{IL} | Input LOW voltage | | –0.3 | – | $0.25 \times V_{DD}$ | V | |
| V_{OL} | Output LOW voltage | $I_{OL} = 3$ mA | – | – | 0.4 | V | |
| $R_{in}^{[3]}$ | Input resistance (WP) | For $V_{IN} = V_{IL}$ (Max) | 40 | – | – | k Ω | |
| | | For $V_{IN} = V_{IH}$ (Min) | 1 | – | – | M Ω | |
| $V_{HYS}^{[4]}$ | Input Hysteresis | | $0.05 \times V_{DD}$ | – | – | V | |

Notes

- Electrostatic Discharge voltages specified in the datasheet are the AEC-Q100 standard limits used for qualifying the device. To know the maximum value device passes for, please refer to the [device qualification report](#) available on the website.
- Typical values are at 25 °C, $V_{DD} = V_{DD}$ (typ). Not 100% tested.
- The input pull-down circuit is strong (40 k Ω) when the input voltage is below V_{IL} and weak (1 M Ω) when the input voltage is above V_{IH} .
- These parameters are guaranteed by design and are not tested.

Data Retention and Endurance

| Parameter | Description | Test condition | Min | Max | Unit |
|-----------------|----------------|----------------------------|------------------|-----|--------|
| T _{DR} | Data retention | T _A = 125 °C | 11000 | – | Hours |
| | | T _A = 105 °C | 11 | – | Years |
| | | T _A = 85 °C | 121 | – | Years |
| NV _C | Endurance | Over Operating Temperature | 10 ¹³ | – | Cycles |

Example of an F-RAM Life Time in an AEC-Q100 Automotive Application

An application does not operate under a steady temperature for the entire usage life time of the application. Instead, it is often expected to operate in multiple temperature environments throughout the application’s usage life time. Accordingly, the retention specification for F-RAM in applications often needs to be calculated cumulatively. An example calculation for a multi-temperature thermal profiles is given below.

| Temperature T | Time Factor t | Acceleration Factor with respect to Tmax A [5] | Profile Factor P | Profile Life Time L (P) |
|------------------|------------------|--|--|----------------------------|
| | | $A = \frac{L(T)}{L(T_{max})} = e^{\frac{E_a}{k} \left(\frac{1}{T} - \frac{1}{T_{max}} \right)}$ | $P = \frac{1}{\left(\frac{t_1}{A_1} + \frac{t_2}{A_2} + \frac{t_3}{A_3} + \frac{t_4}{A_4} \right)}$ | L(P) = P × L(Tmax) |
| T1 = 125 °C | t1 = 0.1 | A1 = 1 | 8.33 | > 10.46 Years |
| T2 = 105 °C | t2 = 0.15 | A2 = 8.67 | | |
| T3 = 85 °C | t3 = 0.25 | A3 = 95.68 | | |
| T4 = 55 °C | t4 = 0.50 | A4 = 6074.80 | | |

Capacitance

| Parameter [6] | Description | Test Conditions | Max | Unit |
|----------------|------------------------------|--|-----|------|
| C _O | Output pin capacitance (SDA) | T _A = 25 °C, f = 1 MHz, V _{DD} = V _{DD} (typ) | 8 | pF |
| C _I | Input pin capacitance | | 6 | pF |

Thermal Resistance

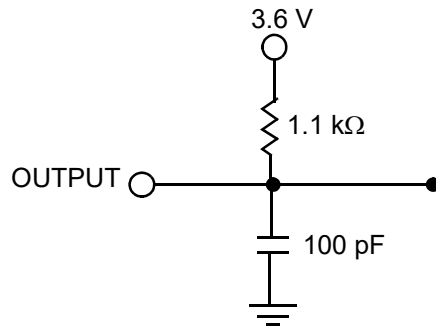
| Parameter [6] | Description | Test Conditions | 8-pin SOIC | Unit |
|-----------------|--|--|------------|------|
| Θ _{JA} | Thermal resistance (junction to ambient) | Test conditions follow standard test methods and procedures for measuring thermal impedance, per EIA/JESD51. | 147 | °C/W |
| Θ _{JC} | Thermal resistance (junction to case) | | 47 | °C/W |

Notes

- Where k is the Boltzmann constant 8.617 × 10⁻⁵ eV/K, Tmax is the highest temperature specified for the product, and T is any temperature within the F-RAM product specification. All temperatures are in Kelvin in the equation.
- This parameter is periodically sampled and not 100% tested.

AC Test Loads and Waveforms

Figure 12. AC Test Loads and Waveforms



AC Test Conditions

Input pulse levels 10% and 90% of V_{DD}
 Input rise and fall times 10 ns
 Input and output timing reference levels $0.5 \times V_{DD}$
 Output load capacitance 100 pF

AC Switching Characteristics

Over the [Operating Range](#)

| Parameter ^[7] | | Description | Min | Max | Min | Max | Min | Max | Unit |
|--------------------------|----------------|---|-----|------|-----|-----|------|------|---------|
| Cypress Parameter | Alt. Parameter | | | | | | | | |
| f_{SCL} ^[8] | | SCL clock frequency | – | 0.1 | – | 0.4 | – | 1.0 | MHz |
| $t_{SU;STA}$ | | Start condition setup for repeated Start | 4.7 | – | 0.6 | – | 0.25 | – | μ s |
| $t_{HD;STA}$ | | Start condition hold time | 4.0 | – | 0.6 | – | 0.25 | – | μ s |
| t_{LOW} | | Clock LOW period | 4.7 | – | 1.3 | – | 0.6 | – | μ s |
| t_{HIGH} | | Clock HIGH period | 4.0 | – | 0.6 | – | 0.4 | – | μ s |
| $t_{SU;DAT}$ | $t_{SU;DATA}$ | Data in setup | 250 | – | 100 | – | 100 | – | ns |
| $t_{HD;DAT}$ | $t_{HD;DATA}$ | Data in hold | 0 | – | 0 | – | 0 | – | ns |
| t_{DH} | | Data output hold (from SCL @ V_{IL}) | 0 | – | 0 | – | 0 | – | ns |
| t_R ^[9] | t_r | Input rise time | – | 1000 | – | 300 | – | 300 | ns |
| t_F ^[9] | t_f | Input fall time | – | 300 | – | 300 | – | 100 | ns |
| $t_{SU;STO}$ | | STOP condition setup | 4.0 | – | 0.6 | – | 0.25 | – | μ s |
| t_{AA} | $t_{VD;DATA}$ | SCL LOW to SDA Data Out Valid | – | 3 | – | 0.9 | – | 0.55 | μ s |
| t_{BUF} | | Bus free before new transmission | 4.7 | – | 1.3 | – | 0.5 | – | μ s |
| t_{SP} | | Noise suppression time constant on SCL, SDA | – | 50 | – | 50 | – | 50 | ns |

Figure 13. Read Bus Timing Diagram

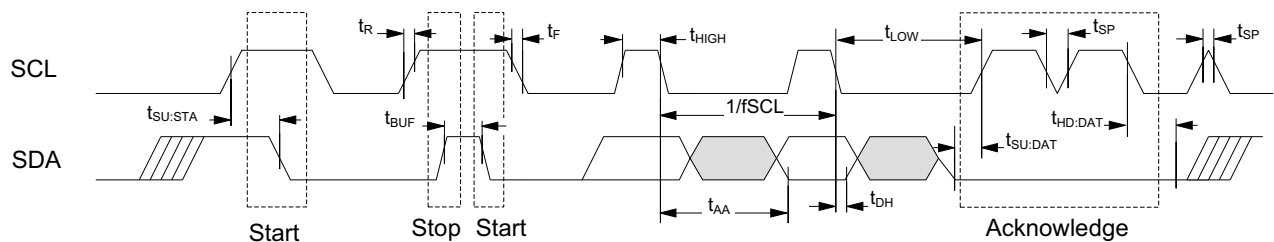
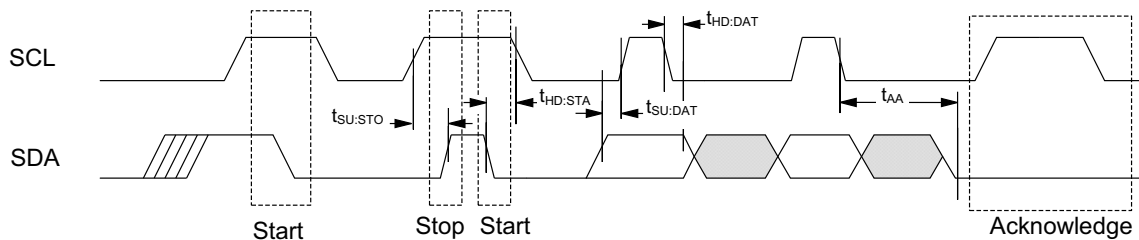


Figure 14. Write Bus Timing Diagram



Notes

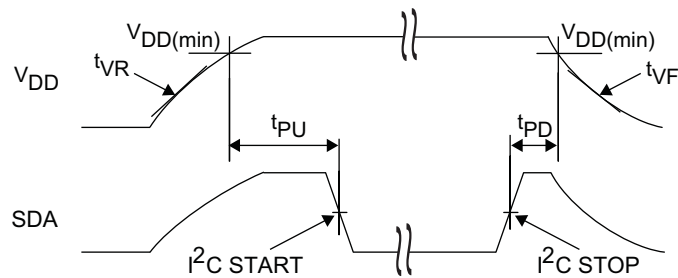
7. Test conditions assume signal transition time of 10 ns or less, timing reference levels of $V_{DD}/2$, input pulse levels of 0 to $V_{DD}(typ)$, and output loading of the specified I_{OL} and load capacitance shown in [Figure 12](#).
8. The speed-related specifications are guaranteed characteristic points along a continuous curve of operation from DC to $f_{SCL} (max)$.
9. These parameters are guaranteed by design and are not tested.

Power Cycle Timing

Over the [Operating Range](#)

| Parameter | Description | Min | Max | Unit |
|---------------------|--|-----|-----|-----------|
| t_{PU} | Power-up $V_{DD(min)}$ to first access (START condition) | 1 | – | ms |
| t_{PD} | Last access (STOP condition) to power-down ($V_{DD(min)}$) | 0 | – | μs |
| $t_{VR}^{[10, 11]}$ | V_{DD} power-up ramp rate | 30 | – | $\mu s/V$ |
| $t_{VF}^{[10, 11]}$ | V_{DD} power-down ramp rate | 30 | – | $\mu s/V$ |

Figure 15. Power Cycle Timing



Notes

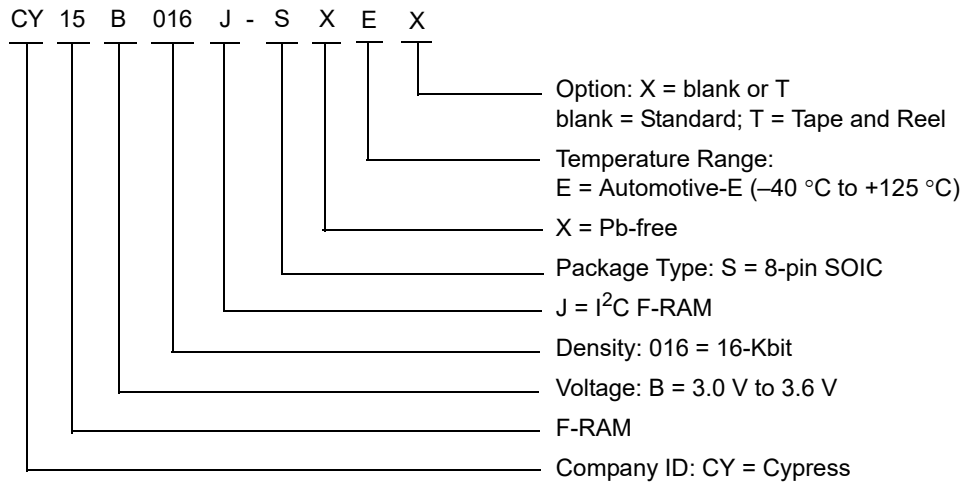
- 10. Slope measured at any point on the V_{DD} waveform.
- 11. Guaranteed by design.

Ordering Information

| Ordering Code | Package Diagram | Package Type | Operating Range |
|----------------|-----------------|--------------|-----------------|
| CY15B016J-SXE | 51-85066 | 8-pin SOIC | Automotive-E |
| CY15B016J-SXET | | | |

All these parts are Pb-free. Contact your local Cypress sales representative for availability of these parts.

Ordering Code Definitions

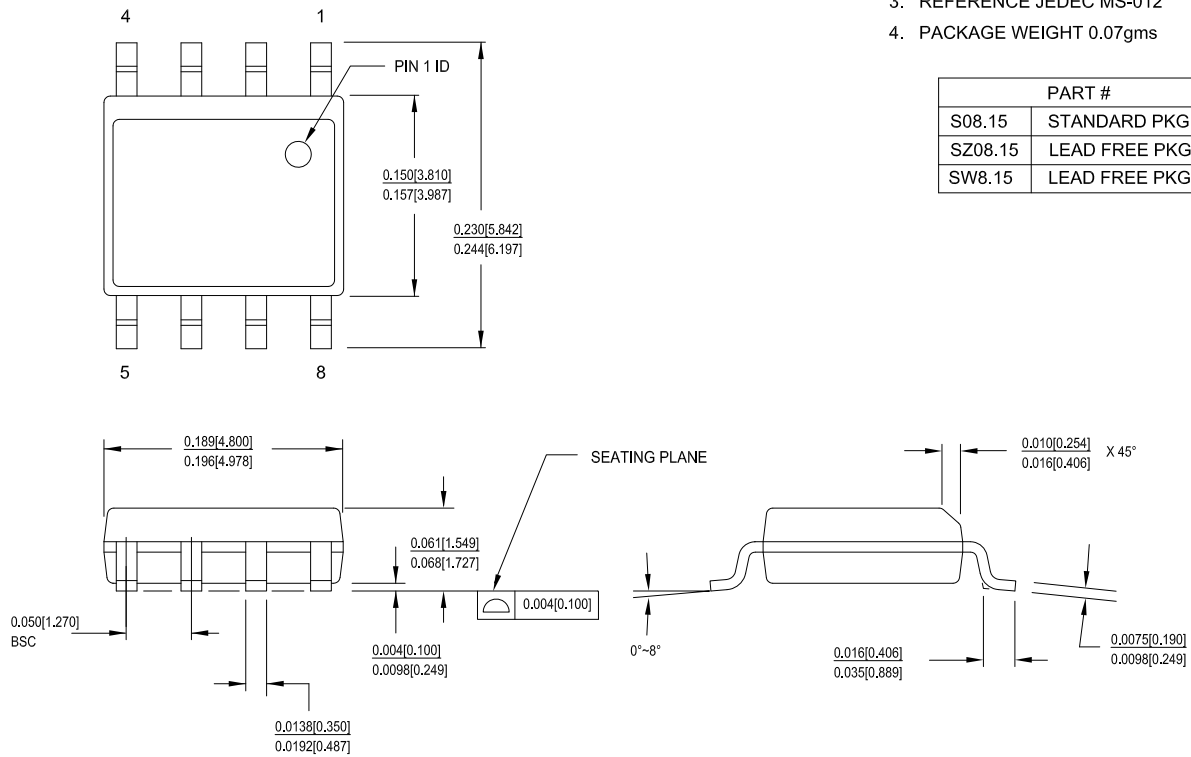


Package Diagram

Figure 16. 8-pin SOIC (150 Mils) Package Outline, 51-85066

1. DIMENSIONS IN INCHES[MM] MIN. MAX.
2. PIN 1 ID IS OPTIONAL, ROUND ON SINGLE LEADFRAME RECTANGULAR ON MATRIX LEADFRAME
3. REFERENCE JEDEC MS-012
4. PACKAGE WEIGHT 0.07gms

| PART # | |
|---------|---------------|
| S08.15 | STANDARD PKG |
| SZ08.15 | LEAD FREE PKG |
| SW8.15 | LEAD FREE PKG |



51-85066 *1

Acronyms

| Acronym | Description |
|------------------|--|
| ACK | Acknowledge |
| CMOS | Complementary Metal Oxide Semiconductor |
| EIA | Electronic Industries Alliance |
| I ² C | Inter-Integrated Circuit |
| I/O | Input/Output |
| JEDEC | Joint Electron Devices Engineering Council |
| LSB | Least Significant Bit |
| MSB | Most Significant Bit |
| NACK | No Acknowledge |
| RoHS | Restriction of Hazardous Substances |
| R \bar{W} | Read/Write |
| SCL | Serial Clock Line |
| SDA | Serial Data Access |
| SOIC | Small Outline Integrated Circuit |
| WP | Write Protect |

Document Conventions

Units of Measure

| Symbol | Unit of Measure |
|--------|-----------------|
| °C | degree Celsius |
| Hz | hertz |
| Kb | 1024 bit |
| kHz | kilohertz |
| kΩ | kilohm |
| MHz | megahertz |
| MΩ | megaohm |
| μA | microampere |
| μs | microsecond |
| mA | milliampere |
| ms | millisecond |
| ns | nanosecond |
| Ω | ohm |
| % | percent |
| pF | picofarad |
| V | volt |
| W | watt |

Document History Page

| Document Title: CY15B016J, 16-Kbit (2K × 8) Serial (I ² C) Automotive-E F-RAM Document Number: 002-10550 | | | | |
|--|---------|-----------------|-----------------|---|
| Rev. | ECN No. | Orig. of Change | Submission Date | Description of Change |
| ** | 5075942 | GVCH | 01/12/2016 | New data sheet. |
| *A | 5564687 | GVCH | 01/27/2017 | <p>Changed status from Preliminary to Final.</p> <p>Updated Maximum Ratings: Updated Electrostatic Discharge Voltage (in compliance with AEC-Q100 standard): Changed value of "Human Body Model" from 4 kV to 2 kV. Changed value of "Charged Device Model" from 1.25 kV to 500 V. Removed Machine Model related information. Updated to new template.</p> |
| *B | 5698510 | GVCH | 04/17/2017 | <p>Updated Maximum Ratings: Added Note 1 and referred the same note in "Electrostatic Discharge Voltage". Updated to new template.</p> |
| *C | 6391441 | GVCH | 11/22/2018 | <p>Updated Maximum Ratings: Replaced "-55 °C to +150 °C" with "-65 °C to +150 °C" in ratings corresponding to "Storage temperature". Updated Package Diagram: spec 51-85066 – Changed revision from *H to *I. Updated to new template. Completing Sunset Review.</p> |

Sales, Solutions, and Legal Information

Worldwide Sales and Design Support

Cypress maintains a worldwide network of offices, solution centers, manufacturer's representatives, and distributors. To find the office closest to you, visit us at [Cypress Locations](#).

Products

| | |
|---|--|
| Arm [®] Cortex [®] Microcontrollers | cypress.com/arm |
| Automotive | cypress.com/automotive |
| Clocks & Buffers | cypress.com/clocks |
| Interface | cypress.com/interface |
| Internet of Things | cypress.com/iot |
| Memory | cypress.com/memory |
| Microcontrollers | cypress.com/mcu |
| PSoC | cypress.com/psoc |
| Power Management ICs | cypress.com/pmic |
| Touch Sensing | cypress.com/touch |
| USB Controllers | cypress.com/usb |
| Wireless Connectivity | cypress.com/wireless |

PSoC[®] Solutions

[PSoC 1](#) | [PSoC 3](#) | [PSoC 4](#) | [PSoC 5LP](#) | [PSoC 6 MCU](#)

Cypress Developer Community

[Community](#) | [Projects](#) | [Video](#) | [Blogs](#) | [Training](#) | [Components](#)

Technical Support

cypress.com/support

© Cypress Semiconductor Corporation, 2016–2018. This document is the property of Cypress Semiconductor Corporation and its subsidiaries, including Spansion LLC ("Cypress"). This document, including any software or firmware included or referenced in this document ("Software"), is owned by Cypress under the intellectual property laws and treaties of the United States and other countries worldwide. Cypress reserves all rights under such laws and treaties and does not, except as specifically stated in this paragraph, grant any license under its patents, copyrights, trademarks, or other intellectual property rights. If the Software is not accompanied by a license agreement and you do not otherwise have a written agreement with Cypress governing the use of the Software, then Cypress hereby grants you a personal, non-exclusive, nontransferable license (without the right to sublicense) (1) under its copyright rights in the Software (a) for Software provided in source code form, to modify and reproduce the Software solely for use with Cypress hardware products, only internally within your organization, and (b) to distribute the Software in binary code form externally to end users (either directly or indirectly through resellers and distributors), solely for use on Cypress hardware product units, and (2) under those claims of Cypress's patents that are infringed by the Software (as provided by Cypress, unmodified) to make, use, distribute, and import the Software solely for use with Cypress hardware products. Any other use, reproduction, modification, translation, or compilation of the Software is prohibited.

TO THE EXTENT PERMITTED BY APPLICABLE LAW, CYPRESS MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARD TO THIS DOCUMENT OR ANY SOFTWARE OR ACCOMPANYING HARDWARE, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE. No computing device can be absolutely secure. Therefore, despite security measures implemented in Cypress hardware or software products, Cypress does not assume any liability arising out of any security breach, such as unauthorized access to or use of a Cypress product. In addition, the products described in these materials may contain design defects or errors known as errata which may cause the product to deviate from published specifications. To the extent permitted by applicable law, Cypress reserves the right to make changes to this document without further notice. Cypress does not assume any liability arising out of the application or use of any product or circuit described in this document. Any information provided in this document, including any sample design information or programming code, is provided only for reference purposes. It is the responsibility of the user of this document to properly design, program, and test the functionality and safety of any application made of this information and any resulting product. Cypress products are not designed, intended, or authorized for use as critical components in systems designed or intended for the operation of weapons, weapons systems, nuclear installations, life-support devices or systems, other medical devices or systems (including resuscitation equipment and surgical implants), pollution control or hazardous substances management, or other uses where the failure of the device or system could cause personal injury, death, or property damage ("Unintended Uses"). A critical component is any component of a device or system whose failure to perform can be reasonably expected to cause the failure of the device or system, or to affect its safety or effectiveness. Cypress is not liable, in whole or in part, and you shall and hereby do release Cypress from any claim, damage, or other liability arising from or related to all Unintended Uses of Cypress products. You shall indemnify and hold Cypress harmless from and against all claims, costs, damages, and other liabilities, including claims for personal injury or death, arising from or related to any Unintended Uses of Cypress products.

Cypress, the Cypress logo, Spansion, the Spansion logo, and combinations thereof, WICED, PSoC, CapSense, EZ-USB, F-RAM, and Traveo are trademarks or registered trademarks of Cypress in the United States and other countries. For a more complete list of Cypress trademarks, visit cypress.com. Other names and brands may be claimed as property of their respective owners.

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for [F-RAM](#) category:

Click to view products by [Cypress](#) manufacturer:

Other Similar products are found below :

[FM24C64B-GTR](#) [FM25640B-G](#) [FM24V05-GTR](#) [FM28V020-T28G](#) [FM24V02A-GTR](#) [FM24W256-GTR](#) [FM25V02A-DGTR](#) [CY15B108QI-20LPXC](#) [FM22L16-55-TG](#) [FM24C04B-G](#) [FM24C04B-GTR](#) [FM24C16B-GTR](#) [FM24C64B-G](#) [FM24CL04B-GTR](#) [FM24CL16B-GTR](#) [FM24CL64B-GTR](#) [FM25040B-GTR](#) [FM25CL64B-GTR](#) [FM25L04B-GTR](#) [FM25L16B-GTR](#) [FM24V10-GTR](#) [FM25V02A-DG](#) [FM25V02A-GTR](#) [FM28V020-SG](#) [FM28V100-TG](#) [FM31256-G](#) [FM31256-GTR](#) [FM3164-G](#) [MB85R4001ANC-GE1](#) [FM25V01A-GTR](#) [FM25V10-GTR](#) [FM25W256-GTR](#) [FM25W256-G](#) [MR45V200BRAZAARL](#) [MR48V256CTAZAARL](#) [MB85RS512TPNF-G-JNERE1](#) [MB85RC1MTPNF-G-JNERE1](#) [MB85RS128BPNF-G-JNERE1](#) [MB85RS1MTPNF-G-JNERE1](#) [MB85RS64VPNF-G-JNERE1](#) [MB85RC128APNF-G-JNERE1](#) [MB85RC256VPF-G-JNERE2](#) [MB85R4002ANC-GE1](#) [CY15B104QI-20LPXC](#) [FM24C16B-G](#) [FM24CL64B-DG](#) [FM25CL64B-DG](#) [FM25L16B-DG](#) [FM25L16B-G](#) [FM25V05-G](#)